

**Search Notes**

Application No.

10/049,570

Examiner

Anthony Weier

Applicant(s)

TAKAHASHI ET AL.

Art Unit

1761

**SEARCHED**

Class	Subclass	Date	Examiner
426	594, 618		
	637,	9/29/2003	AW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR